Search Notes			

_	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/608,595	WATANABE ET AL.	
	Examiner	Art Unit	
	DANH C. LE	2617	

SEARCHED				
Class	Subclass	Date	Examiner	
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456	575.3	62507	PL	
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3719	433,13			
361	683			
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INTERFERENCE SEARCHED				
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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